

**Search Notes**

Application/Control No.

09/886,255

Examiner

Jacob Meek

Applicant(s)/Patent under  
Reexamination

DENNO, SATOSHI

Art Unit

2637

**SEARCHED**

Class	Subclass	Date	Examiner
375	235,343 349,345 344	6/22/2005	JM
329	304,318	6/22/2005	JM
329	341	6/22/2005	JM
455	324,305	6/22/2005	JM
455	239.1,337	6/22/2005	JM
455	245.1,303	6/22/2005	JM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
375	316	6/22/2005	JM

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	6/22/2005	JM
NPL	6/22/2005	JM